



REPORT No. : SZ18080134S03

FCC TEST REPORT

APPLICANT : Shenzhen Snoppa Technology Co., Ltd
PRODUCT NAME : ATOM
MODEL NAME : ATOM
BRAND NAME : Snoppa
FCC ID : 2AIXRATOM
STANDARD(S) : 47CFR 2.1091
TEST DATE : 2018-11-29
ISSUE DATE : 2018-11-30

Edited by:

Handwritten signature of Liang Yumei in black ink.

Liang Yumei (Rapporteur)

Approved by:

Handwritten signature of Peng Huarui in black ink.

Peng Huarui (Supervisor)

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MORLAB

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.
FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,
Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China

Tel: 86-755-36698555

Fax: 86-755-36698525

Http://www.morlab.cn

E-mail: service@morlab.cn



DIRECTORY

1. Technical Information	4
1.1. Applicant and Manufacturer Information	4
1.2. Equipment Under Test (EUT) Description	4
1.3. Photographs of the EUT	5
1.4. Applied Reference Documents	5
2. FCC MPE Requirement	5
2.1. General Information	5
2.2. MPE Limit	5
2.3. Measurement Uncertainty (95% confidence levels, k=2)	6
2.4. Test Information	6
2.5. Test Setup	6
3. Assess Results	7
3.1. Test Equipment List	7
3.2. Test Results	8
Annex A General Information	
Annex B Test Setup Photos	



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Change History		
Issue	Date	Reason for change
1.0	2018-11-30	First edition



1. Technical Information

Note: Provide by manufacturer.

1.1. Applicant and Manufacturer Information

Applicant:	Shenzhen Snoppa Technology Co., Ltd.
Applicant Address:	Room 410, No.2 Nanhai E Cool building, Xinghua Road, Shekou, Nanshan District, Shenzhen, China
Manufacturer:	Shenzhen Snoppa Technology Co., Ltd.
Manufacturer Address:	Room 410, No.2 Nanhai E Cool building, Xinghua Road, Shekou, Nanshan District, Shenzhen, China

1.2. Equipment Under Test (EUT) Description

EUT Type:	ATOM		
Hardware Version:	v2.0		
Software Version:	V2.0.21		
Frequency Bands:	110 KHz ~ 205 KHz		
MPE:	E-field	0.59 V/m	50%Limit: 307(V/m)
	H-field	0.0.101A/m	50%Limit: 0.815(A/m)



1.3. Photographs of the EUT

Please refer to the External Photos for the Photos of the EUT

1.4. Applied Reference Documents

Leading reference documents for testing:

No.	Identity	Document Title
1	47 CFR§2.1091	Radiofrequency Radiation Exposure Evaluation: Mobile Devices
2	680106 D01v03	RF Exposure Considerations for Low Power Consumer Wireless Power Transfer Applications

2. FCC MPE Requirement

2.1. General Information

For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 15 cm. E and H field strength measurements or numerical modeling may be used to demonstrate compliance.

Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device. Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m. A KDB inquiry is required to determine the applicable exposure limits below 100 kHz.

2.2. MPE Limit

Basic Restrictions Reference levels

Basic Restriction for electric, magnetic and electromagnetic fields (0Hz to 300GHz)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposure				
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f ²	6
30-300	61.4	0.163	1.0	6
300-1,500			f/300	6
1,500-100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f ²	30
30-300	27.5	0.073	0.2	30
300-1,500			f/1500	30
1,500-100,000			1.0	30

f = frequency in MHz * = Plane-wave equivalent power density

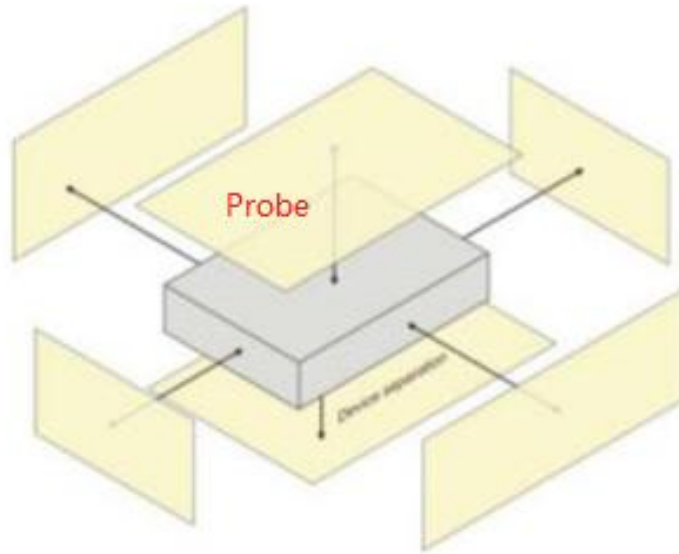
2.3. Measurement Uncertainty (95% confidence levels, k=2)

Test Item	Uncertainty
Uncertainty for Radiated Frequency	7*10 ⁸
Uncertainty for test site temperature and humidity	0.6 °C
	3%

2.4. Test Information

The EUT working at normal charging mode, use the E-Probe measure the H-field Strength, E-field Strength separately.

2.5. Test Setup



3. Assess Results

3.1. Test Equipment List

Manufacturer	Name of Equipment	Type/Model	Serial Number	Calibration	
				Last Cal.	Due Date
STT	Broadband Field meter	SEM-600	D-1044	2018.05.29	2019.05.28
STT	Probe	LF-04	I-1044	2018.05.29	2019.05.28
STT	Probe holder	TR-01	N/A	N/A	N/A
STT	Optical fiber line	L=5M	N/A	N/A	N/A

3.2. Test Results

EUT: Wireless charger	Test Date: 2018.11.29
Temperature: 25 ± 2 °C	Humidity: 20-60%

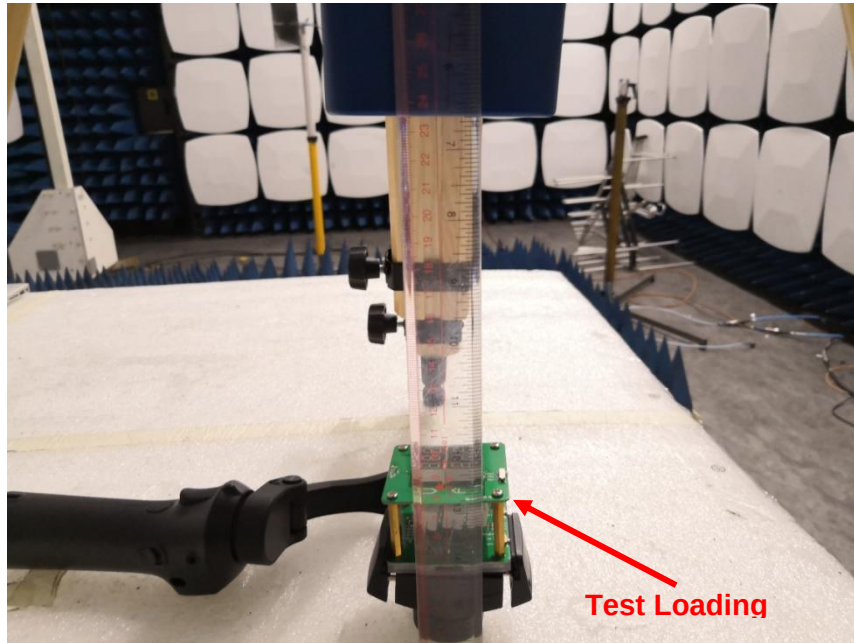
E field strength result (Test frequency range from 110 KHz ~ 205 KHz)					
Test Loading	Exposure Position	Distance (cm)	E-field Strength (Max. V/m)	Limit 50%(V/m)	Result
205K 5V	Front Surface	20	0.39	307	PASS
	Back Surface	15	0.59	307	PASS
	Left Side	15	0.35	307	PASS
	Right Side	15	0.43	307	PASS
	Top Side	15	0.32	307	PASS
	Bottom Side	15	0.45	307	PASS

H- field strength result (Test frequency range from 110 KHz ~ 205 KHz)					
Test Loading	Exposure Position	Distance (cm)	H-field Strength (Max. A/m)	Limit 50%(A/m)	Result
205K 5V	Front Surface	20	0.023	0.815	PASS
	Back Surface	15	0.027	0.815	PASS
	Left Side	15	0.048	0.815	PASS
	Right Side	15	0.034	0.815	PASS
	Top Side	15	0.019	0.815	PASS
	Bottom Side	15	0.020	0.815	PASS

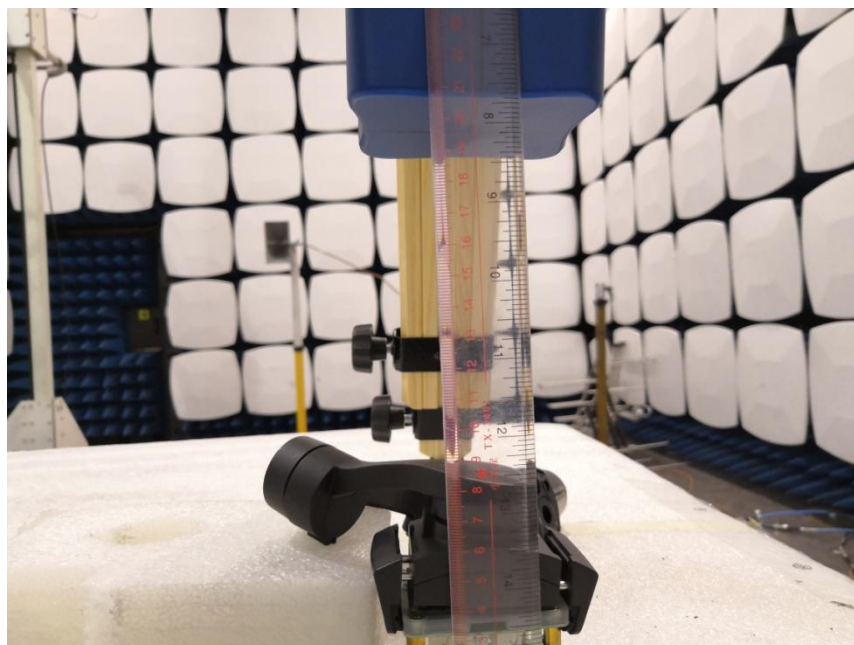
Note:

1. This device designed for typical desktop applications, therefore mobile exposure conditions are applied and client device is placed directly in contact with the transmitter.
2. According to the user manual, output power from each primary coil is less than or equal to 15 watts.
3. According to KDB 680106 D01V03 section 5 b), the aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit

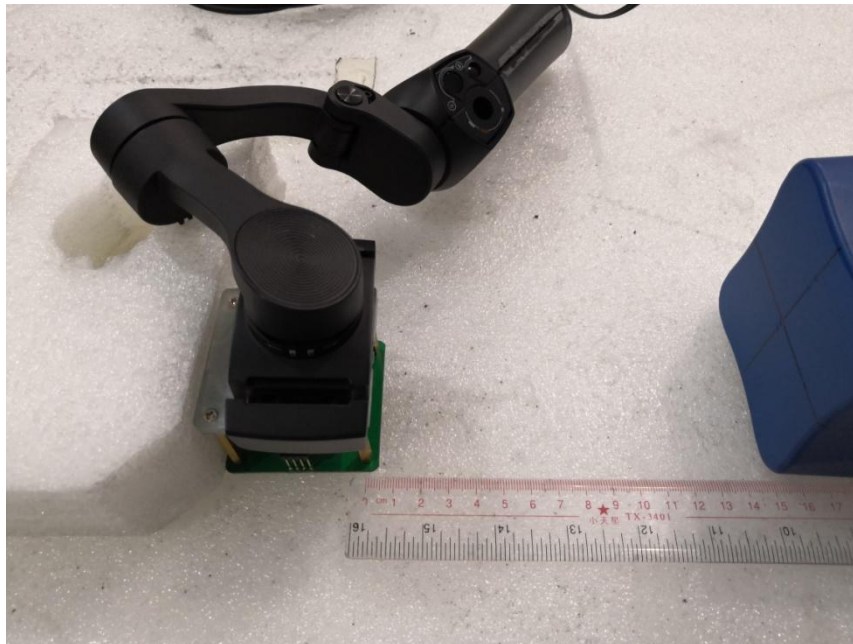
Annex B Test Setup Photos



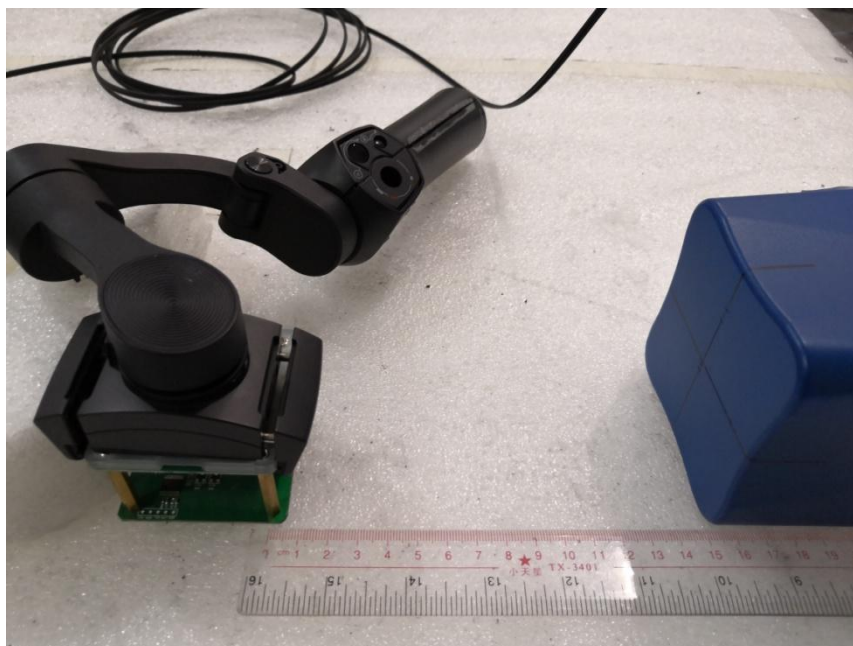
Front Surface_20cm



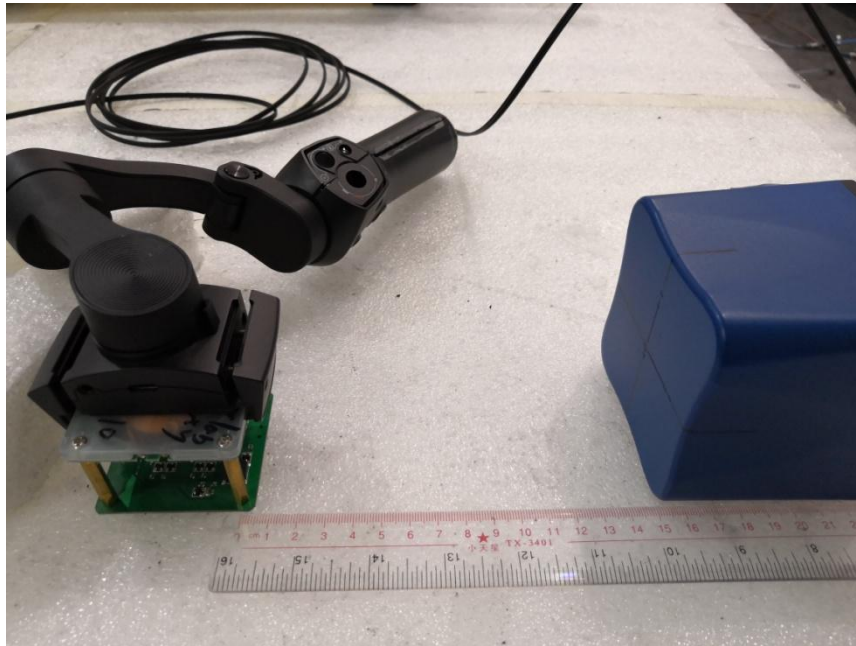
Back Surface_15cm



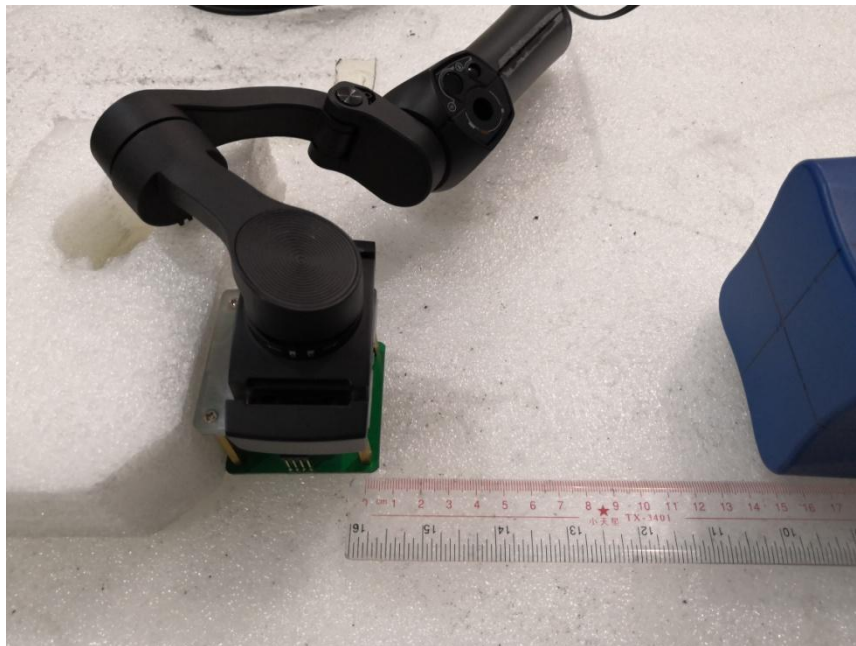
Top Side_15cm



Left Side _15cm



Right Side_15cm



Bottom Side _15cm